

BUK100-50GL-VB Datasheet N-Channel 60 V(D-S) MOSFET

| PRODUCT SUMMARY | | | | | |
|--------------------------|------------------------------|--|--|--|--|
| V _{DS} (V) | 60 | | | | |
| R _{DS(on)} (Ω) | V _{GS} = 10 V 0.072 | | | | |
| Q _g max. (nC) | 25 | | | | |
| Q _{gs} (nC) | 5.8 | | | | |
| Q _{gd} (nC) | 11 | | | | |
| Configuration | Single | | | | |

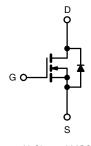
FEATURES

- Dynamic dV/dt rating
- · Fast switching
- Ease of paralleling

Simple drive requirements







N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS ($T_C = 25 \text{ °C}$, unless otherwise noted) | | | | | | |
|---|------------------------|--|-----------------------------------|-------------|----------|--|
| PARAMETER | | | SYMBOL | LIMIT | UNIT | |
| Drain-Source Voltage | | | V _{DS} | 60 | V | |
| Gate-Source Voltage | | | V _{GS} | ± 20 | V | |
| Continuous Drain Current | V at 10 V | $T_{C} = 25 \text{ °C}$ $T_{C} = 100 \text{ °C}$ | 1 | 20 | А | |
| Continuous Drain Current | V_{GS} at 10 V T_C | T _C = 100 °C | Ι _D | 12 | | |
| Pulsed Drain Current ^a | | | I _{DM} | 68 | 1 | |
| Linear Derating Factor | | | | 0.40 | W/°C | |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 100 | mJ | |
| Maximum Power Dissipation | T _C = 25 °C | | PD | 60 | W | |
| Peak Diode Recovery dV/dt ^c | | | dV/dt | 4.5 | V/ns | |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | -55 to +175 | °C | |
| Soldering Recommendations (Peak temperature) ^d | for 10 s | | | 300 | 7 | |
| Mounting Torque | 6 20 or l | | | 10 | lbf ∙ in | |
| Mounting Torque | 6-32 or M3 screw | | | 1.1 | N · m | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

- b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 403 µH, $R_g = 25 \Omega$, $I_{AS} = 17 \text{ A}$ (see fig. 12).
- c. $I_{SD} \leq 17$ A, dl/dt ≤ 140 A/µs, $V_{DD} \leq V_{DS}$, $T_J \leq 175$ °C.

d. 1.6 mm from case.

BUK100-50GL-VB



| THERMAL RESISTANCE RATINGS | | | | |
|-------------------------------------|-------------------|------|------|------|
| PARAMETER | SYMBOL | TYP. | MAX. | UNIT |
| Maximum Junction-to-Ambient | R _{thJA} | - | 62 | |
| Case-to-Sink, Flat, Greased Surface | R _{thCS} | 0.50 | - | °C/W |
| Maximum Junction-to-Case (Drain) | R _{thJC} | - | 2.5 | |

| PARAMETER | SYMBOL | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT |
|---|------------------------|---|---|------|------------------|-------|------|
| Static | | | | • | | • | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = | = 0 V, I _D = 250 μA | 60 | - | - | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | Referenc | e to 25 °C, I _D = 1 mA | - | 0.061 | - | V/°C |
| Gate-Source Threshold Voltage | V _{GS(th)} | V _{DS} = | : V _{GS} , I _D = 250 μΑ | 1.0 | - | 3.0 | V |
| Gate-Source Leakage | I _{GSS} | , | V _{GS} = ± 20 V | - | - | ± 100 | nA |
| Zero Gate Voltage Drain Current | 1 | $V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$ | | - | - | 25 | |
| zero date voltage Drain Current | I _{DSS} | V _{DS} = 48 V | V_{GS} = 0 V, T_J = 150 °C | - | - | 250 | μA |
| Drain-Source On-State Resistance | R _{DS(on)} | $V_{GS} = 10 V$ | I _D = 10 A ^b | - | 0.072 | - | Ω |
| Forward Transconductance | g _{fs} | V _{DS} | = 25 V, I _D = 10 A | 5.5 | - | - | S |
| Dynamic | | | | | | | |
| Input Capacitance | C _{iss} | | $V_{GS} = 0 V$, | - | 640 | - | |
| Output Capacitance | C _{oss} | | $V_{DS} = 25 V,$ | - | 360 | - | pF |
| Reverse Transfer Capacitance | C _{rss} | t = 1. | 0 MHz, see fig. 5 | - | 79 | - | |
| Total Gate Charge | Qg | | | - | - | 25 | |
| Gate-Source Charge | Q_gs | $V_{GS} = 10 V$ $I_D = 17 A, V_{DS} = 48 V,$ see fig. 6 and 13 ^b | | - | - | 5.8 | nC |
| Gate-Drain Charge | Q _{gd} | | 3 | - | - | 11 | 1 |
| Turn-On Delay Time | t _{d(on)} | | | - | 13 | - | |
| Rise Time | t _r | $V_{DD} = 30 \text{ V}, \text{ I}_D = 17 \text{ A},$ $\text{R}_g = 18 \ \Omega, \ \text{R}_D = 1.7 \ \Omega, \text{ see fig. 10}^{\text{ b}}$ | | - | 58 | - | - ns |
| Turn-Off Delay Time | t _{d(off)} | | | - | 25 | - | |
| Fall Time | t _f | | | - | 42 | - | |
| Internal Drain Inductance | L _D | Between lead, 6 mm (0.25") from package and center of die contact | | - | 4.5 | - | |
| Internal Source Inductance | L _S | | | - | 7.5 | - | nH |
| Drain-Source Body Diode Characteristic | s | | | | • | | |
| Continuous Source-Drain Diode Current | I _S | MOSFET symbol showing the integral reverse p - n junction diode | | - | - | 20 | |
| Pulsed Diode Forward Current ^a | I _{SM} | | | - | - | 68 | A |
| Body Diode Voltage | V _{SD} | $T_{\rm J}$ = 25 °C, $I_{\rm S}$ = 17 A, $V_{\rm GS}$ = 0 V ^b | | - | - | 1.5 | V |
| Body Diode Reverse Recovery Time | t _{rr} | $T_J = 25 \text{ °C}, I_F = 17 \text{ A}, dl/dt = 100 \text{ A}/\mu\text{s}$ | | - | 88 | 180 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | | | - | 0.29 | 0.64 | μC |
| Forward Turn-On Time | t _{on} | Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D) | | | L _D) | | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

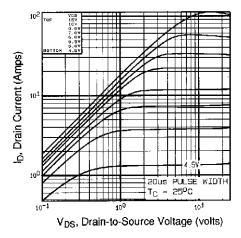


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

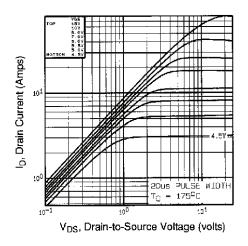


Fig. 2 - Typical Output Characteristics, T_C = 175 °C

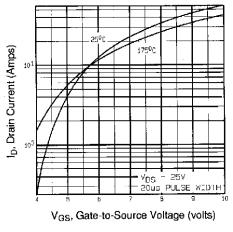


Fig. 3 - Typical Transfer Characteristics

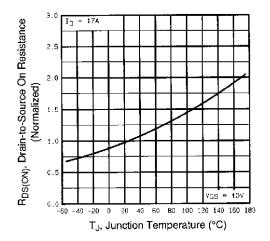


Fig. 4 - Normalized On-Resistance vs. Temperature

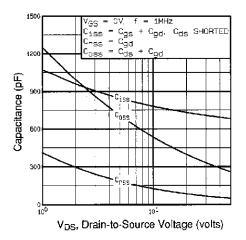


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

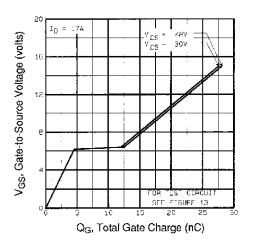


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



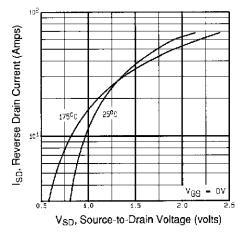


Fig. 7 - Typical Source-Drain Diode Forward Voltage

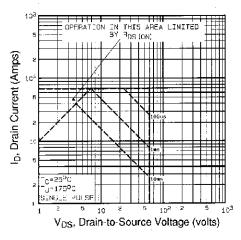


Fig. 8 - Maximum Safe Operating Area

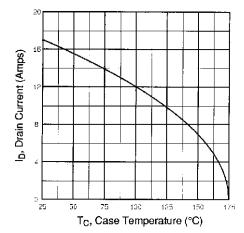


Fig. 9 - Maximum Drain Current vs. Case Temperature

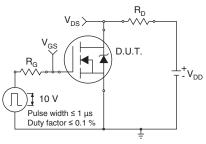


Fig. 10a - Switching Time Test Circuit

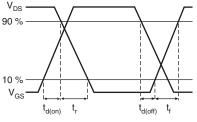
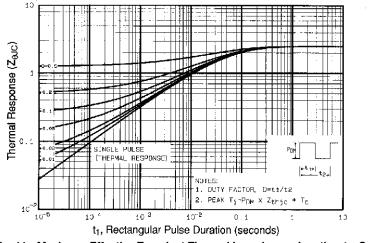


Fig. 10b - Switching Time Waveforms





BUK100-50GL-VB



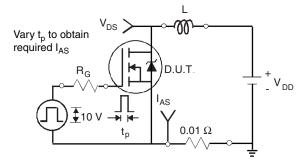


Fig. 12a - Unclamped Inductive Test Circuit

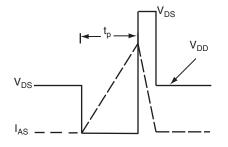


Fig. 12b - Unclamped Inductive Waveforms

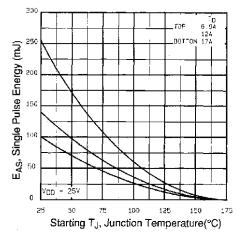


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

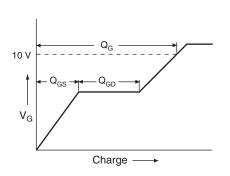


Fig. 13a - Basic Gate Charge Waveform

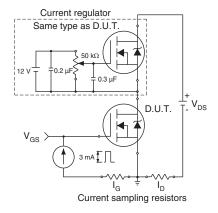
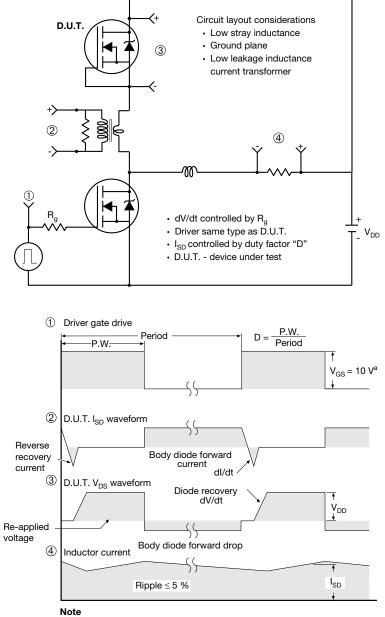


Fig. 13b - Gate Charge Test



Peak Diode Recovery dV/dt Test Circuit

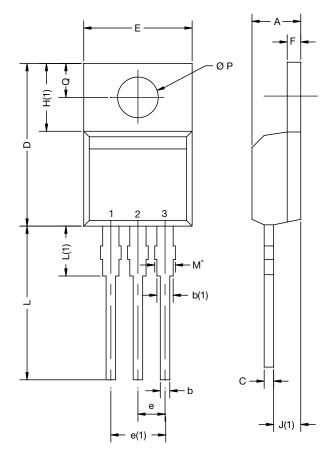


a. $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel



TO-220



| DIM. | MILLIM | IETERS | INCHES | | |
|--|--------|--------|--------|-------|--|
| DINI. | MIN. | MAX. | MIN. | MAX. | |
| А | 4.24 | 4.65 | 0.167 | 0.183 | |
| b | 0.69 | 1.02 | 0.027 | 0.040 | |
| b(1) | 1.14 | 1.78 | 0.045 | 0.070 | |
| С | 0.36 | 0.61 | 0.014 | 0.024 | |
| D | 14.33 | 15.85 | 0.564 | 0.624 | |
| Е | 9.96 | 10.52 | 0.392 | 0.414 | |
| е | 2.41 | 2.67 | 0.095 | 0.105 | |
| e(1) | 4.88 | 5.28 | 0.192 | 0.208 | |
| F | 1.14 | 1.40 | 0.045 | 0.055 | |
| H(1) | 6.10 | 6.71 | 0.240 | 0.264 | |
| J(1) | 2.41 | 2.92 | 0.095 | 0.115 | |
| L | 13.36 | 14.40 | 0.526 | 0.567 | |
| L(1) | 3.33 | 4.04 | 0.131 | 0.159 | |
| ØР | 3.53 | 3.94 | 0.139 | 0.155 | |
| Q | 2.54 | 3.00 | 0.100 | 0.118 | |
| ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031 | | | | | |

Note

- M^{\star} = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



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